



AO4435

P-Channel Enhancement Mode Field Effect Transistor



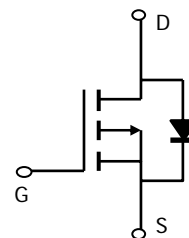
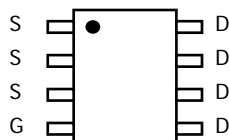
General Description

The AO4435 uses advanced trench technology to provide excellent $R_{DS(ON)}$, and ultra-low low gate charge with a 25V gate rating. This device is suitable for use as a load switch or in PWM applications. Standard Product AO4435 is Pb-free (meets ROHS & Sony 259 specifications).

Features

$V_{DS} = -30V$
 $I_D = -10A$ ($V_{GS} = -10V$)
 $R_{DS(ON)} < 18m\Omega$ ($V_{GS} = -10V$)
 $R_{DS(ON)} < 36m\Omega$ ($V_{GS} = -5V$)

**SOIC-8
Top View**



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | 10 Sec | Steady State | Units | |
|--|----------------|------------------|--------------|------------|---|
| Drain-Source Voltage | V_{DS} | -30 | | V | |
| Gate-Source Voltage | V_{GS} | ±25 | | V | |
| Continuous Drain Current ^A | I_D | $T_A=25^\circ C$ | -10 | -8 | A |
| | | $T_A=70^\circ C$ | -8 | -6 | |
| Pulsed Drain Current ^B | I_{DM} | -80 | | | |
| Power Dissipation ^A | P_D | $T_A=25^\circ C$ | 3.1 | 1.7 | W |
| | | $T_A=70^\circ C$ | 2.0 | 1.1 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | | $^\circ C$ | |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|-----|-----|--------------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 32 | 40 | $^\circ C/W$ |
| $t \leq 10s$ | | | | |
| Maximum Junction-to-Ambient ^A | $R_{\theta JL}$ | 17 | 24 | $^\circ C/W$ |
| Steady State | | | | |
| Maximum Junction-to-Lead ^C | | | | |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|--|------|-------|-----------|---------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D = -250\mu\text{A}$, $V_{GS} = 0\text{V}$ | -30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -30\text{V}$, $V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$ | | | -1 -5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS} = 0\text{V}$, $V_{GS} = \pm 25\text{V}$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}$, $I_D = -250\mu\text{A}$ | -1.7 | -2.3 | -3 | V |
| $I_{D(ON)}$ | On state drain current | $V_{GS} = -10\text{V}$, $V_{DS} = -5\text{V}$ | -80 | | | A |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS} = -10\text{V}$, $I_D = -10\text{A}$ | | 15 | 18 | m Ω |
| | | $T_J = 125^\circ\text{C}$ | | 22 | 27 | |
| | | $V_{GS} = -5\text{V}$, $I_D = -5\text{A}$ | | 27 | 36 | |
| g_{FS} | Forward Transconductance | $V_{DS} = -5\text{V}$, $I_D = -10\text{A}$ | | 22 | | S |
| V_{SD} | Diode Forward Voltage | $I_S = -1\text{A}$, $V_{GS} = 0\text{V}$ | | -0.74 | -1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | -3.5 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}$, $V_{DS}=-15\text{V}$, $f=1\text{MHz}$ | | 1130 | 1400 | pF |
| C_{oss} | Output Capacitance | | 240 | | pF | |
| C_{rss} | Reverse Transfer Capacitance | | 155 | | pF | |
| R_g | Gate resistance | $V_{GS}=0\text{V}$, $V_{DS}=0\text{V}$, $f=1\text{MHz}$ | | 5.8 | 8 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_{g(10V)}$ | Total Gate Charge | $V_{GS}=-10\text{V}$, $V_{DS}=-15\text{V}$, $I_D=-10\text{A}$ | | 18 | 24 | nC |
| $Q_{g(4.5V)}$ | Total Gate Charge | | 9.5 | | | |
| Q_{gs} | Gate Source Charge | | 5.5 | | nC | |
| Q_{gd} | Gate Drain Charge | | 3.3 | | nC | |
| $t_{D(on)}$ | Turn-On Delay Time | $V_{GS}=-10\text{V}$, $V_{DS}=-15\text{V}$, $R_L=1.5\Omega$, $R_{GEN}=3\Omega$ | | 8.7 | | ns |
| t_r | Turn-On Rise Time | | 8.5 | | ns | |
| $t_{D(off)}$ | Turn-Off Delay Time | | 18 | | ns | |
| t_f | Turn-Off Fall Time | | 7 | | ns | |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=-10\text{A}$, $di/dt=100\text{A}/\mu\text{s}$ | | 25 | 30 | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=-10\text{A}$, $di/dt=100\text{A}/\mu\text{s}$ | | 12 | | nC |

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using $< 300\mu\text{s}$ pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

F: The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

G: E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep $T_J=25\text{C}$.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

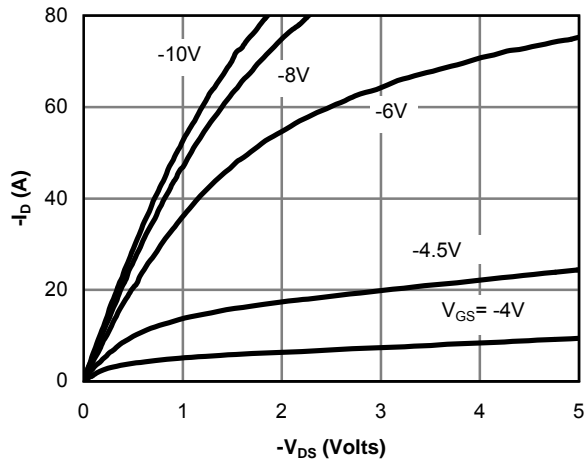


Figure 1: On-Region Characteristics

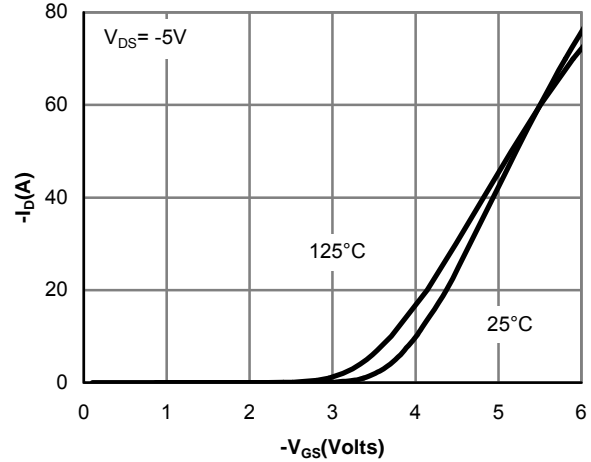


Figure 2: Transfer Characteristics

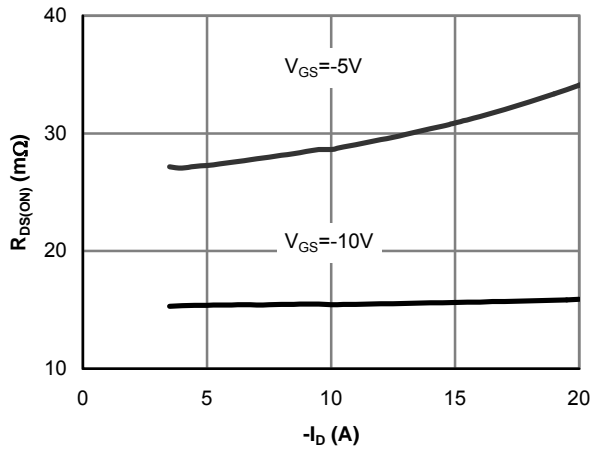


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

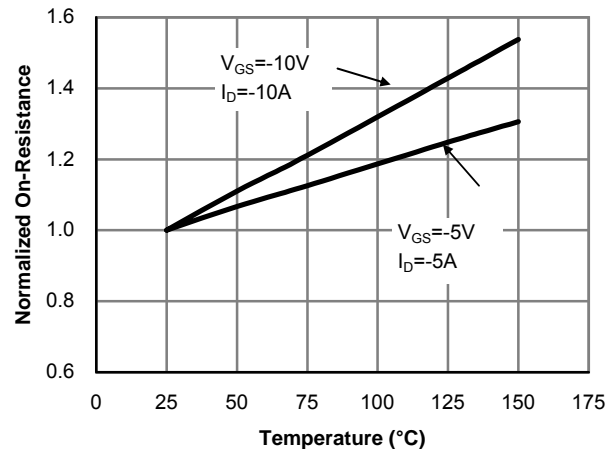


Figure 4: On-Resistance vs. Junction Temperature

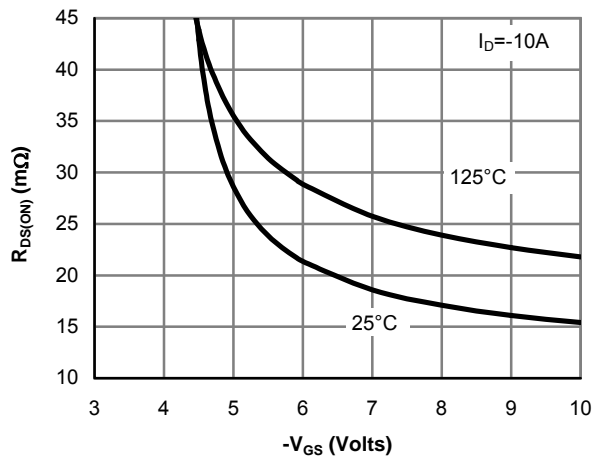


Figure 5: On-Resistance vs. Gate-Source Voltage

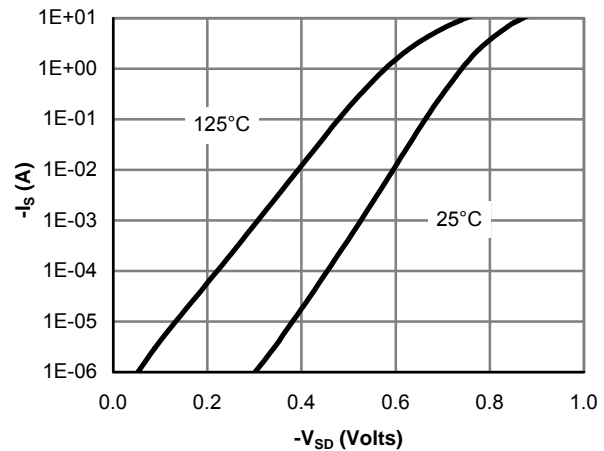


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

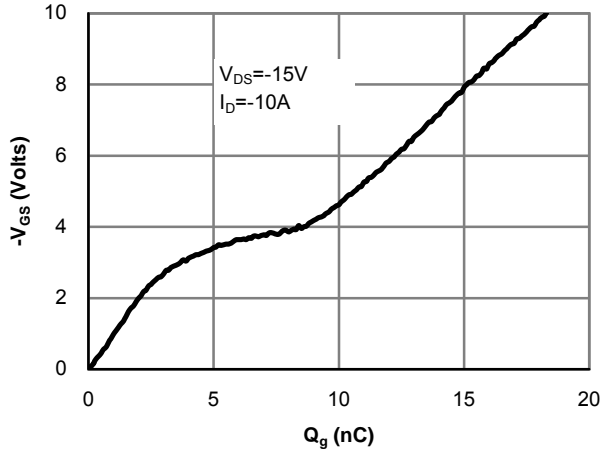


Figure 7: Gate-Charge Characteristics

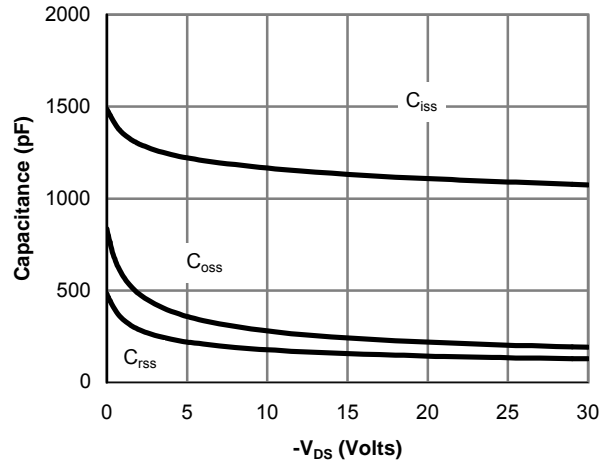


Figure 8: Capacitance Characteristics

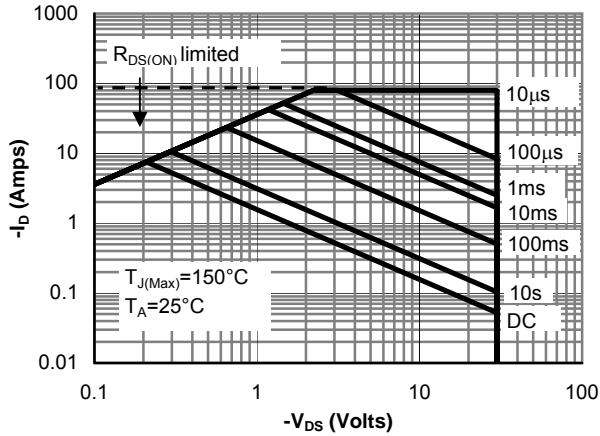


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

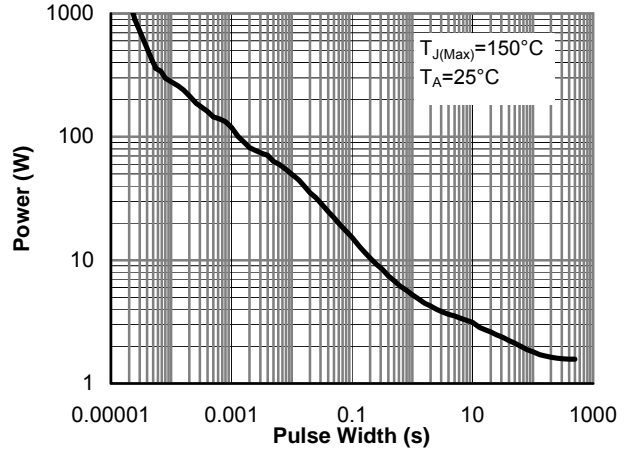


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

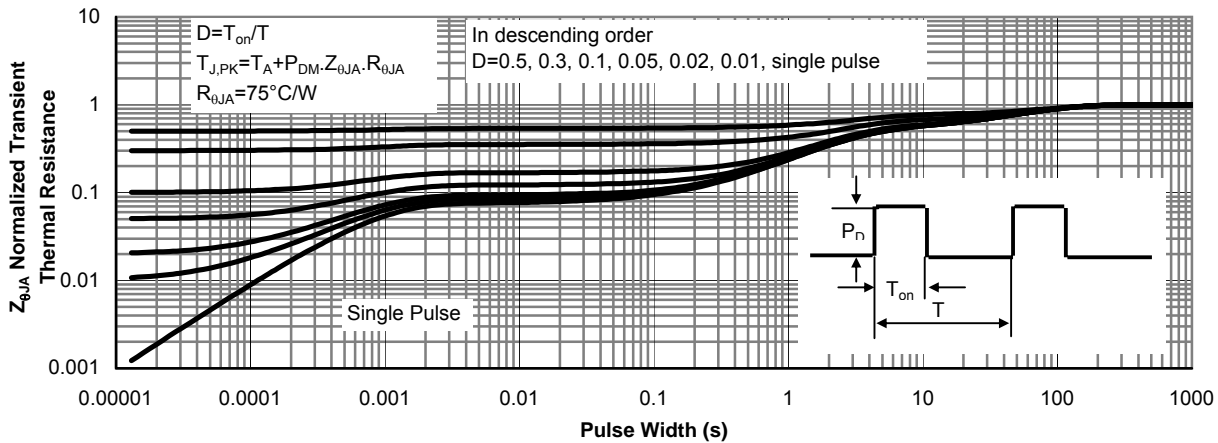


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)